CSD18536KCS 60V N-Channel NexFET™ Power MOSFET

1 Features

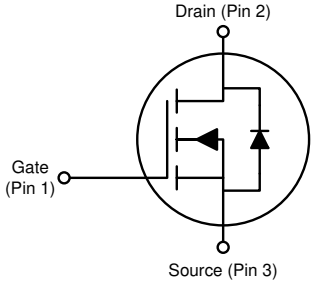
- Ultra-low Q_g and Q_{gd}
- Low thermal resistance
- Avalanche rated
- Pb-free terminal plating
- RoHS compliant
- Halogen free
- TO-220 plastic package

2 Applications

- Secondary side synchronous rectifier
- Motor control

3 Description

This 60V, 1.3mΩ, TO-220 NexFET™ power MOSFET is designed to minimize losses in power conversion applications.



Product Summary

T_A = 25°C		TYPICAL VALUE		UNIT
V_{DS}	Drain-to-Source Voltage	60		V
Q_g	Gate Charge Total (10V)	108		nC
Q_{gd}	Gate Charge Gate-to-Drain	14		nC
$R_{DS(on)}$	Drain-to-Source On-Resistance	V_{GS} = 4.5V	1.7	mΩ
		V_{GS} = 10V	1.3	mΩ
$V_{GS(th)}$	Threshold Voltage	1.8		V

Ordering Information

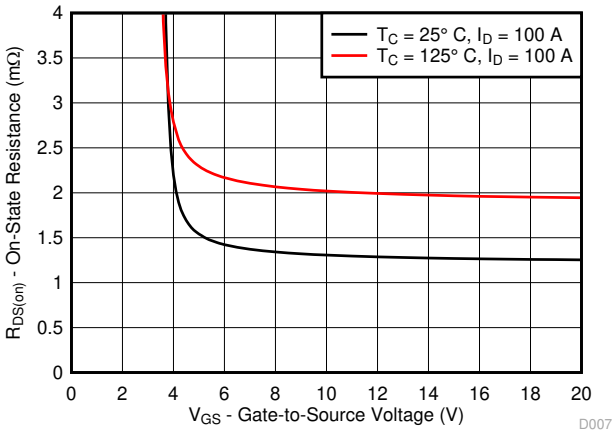
Device(1)	Package	Media	Qty	Ship
CSD18536KCS	TO-220 Plastic Package	Tube	50	Tube

(1) For all available packages, see the orderable addendum at the end of the data sheet.

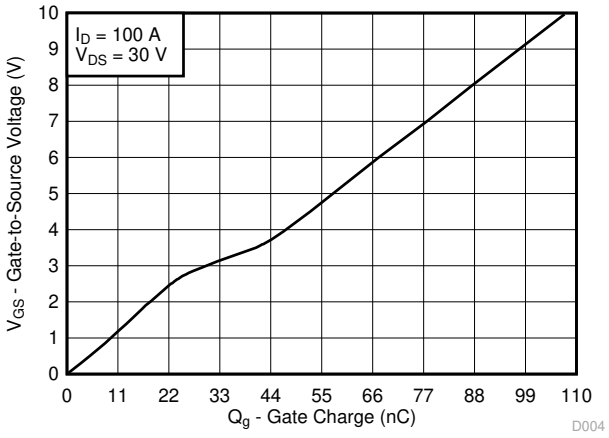
Absolute Maximum Ratings

T_A = 25°C		VALUE	UNIT
V_{DS}	Drain-to-Source Voltage	60	V
V_{GS}	Gate-to-Source Voltage	±20	V
I_D	Continuous Drain Current (Package limited)	200	A
	Continuous Drain Current (Silicon limited), T_C = 25°C	349	
	Continuous Drain Current (Silicon limited), T_C = 100°C	247	
I_{DM}	Pulsed Drain Current (1)	400	A
P_D	Power Dissipation	375	W
T_J, T_{stg}	Operating Junction and Storage Temperature Range	–55 to 175	°C
E_{AS}	Avalanche Energy, single pulse I_D = 128A, L = 0.1mH, R_G = 25Ω	819	mJ

(1) Max $R_{\theta JC}$ = 0.4°C/W, pulse duration ≤100µs, duty cycle ≤1%.



$R_{DS(on)}$ vs V_{GS}



Gate Charge

Table of Contents

4 Specifications

4.1 Electrical Characteristics

(T_A = 25°C unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC CHARACTERISTICS						
BV_{DSS}	Drain-to-Source Voltage	V_{GS} = 0V, I_D = 250µA	60			V
I_{DSS}	Drain-to-Source Leakage Current	V_{GS} = 0V, V_{DS} = 48V			1	µA
I_{GSS}	Gate-to-Source Leakage Current	V_{DS} = 0V, V_{GS} = 20V			100	nA
$V_{GS(th)}$	Gate-to-Source Threshold Voltage	V_{DS} = V_{GS}, I_D = 250µA	1.4	1.8	2.2	V
$R_{DS(on)}$	Drain-to-Source On-Resistance	V_{GS} = 4.5V, I_D = 100A		1.7	2.2	mΩ
		V_{GS} = 10V, I_D = 100A		1.3	1.6	mΩ
g_{fs}	Transconductance	V_{DS} = 6V, I_D = 100A		312		S
DYNAMIC CHARACTERISTICS						
C_{iss}	Input Capacitance	V_{GS} = 0V, V_{DS} = 30V, f = 1MHz		8790	11430	pF
C_{oss}	Output Capacitance			1410	1840	pF
C_{rss}	Reverse Transfer Capacitance			39	51	pF
R_G	Series Gate Resistance			0.7	1.4	Ω
Q_g	Gate Charge Total (10V)	V_{DS} = 30V, I_D = 100A		108	140	nC
Q_{gd}	Gate Charge Gate-to-Drain			14		nC
Q_{gs}	Gate Charge Gate-to-Source			18		nC
$Q_{g(th)}$	Gate Charge at V_{th}			17		nC
Q_{oss}	Output Charge	V_{DS} = 30V, V_{GS} = 0V		230		nC
$t_{d(on)}$	Turn On Delay Time	V_{DS} = 30V, V_{GS} = 10 V, I_{DS} = 100A, R_G = 0Ω		11		ns
t_r	Rise Time			5		ns
$t_{d(off)}$	Turn Off Delay Time			24		ns
t_f	Fall Time			4		ns
DIODE CHARACTERISTICS						
V_{SD}	Diode Forward Voltage	I_{SD} = 100A, V_{GS} = 0V		0.9	1.0	V
Q_{rr}	Reverse Recovery Charge	V_{DS}= 30V, I_F = 100A, di/dt = 300A/µs		323		nC
t_{rr}	Reverse Recovery Time			86		ns

4.2 Thermal Information

(T_A = 25°C unless otherwise stated)

THERMAL METRIC		MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance			0.4	°C/W
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance			62	

4.3 Typical MOSFET Characteristics

(T_A = 25°C unless otherwise stated)

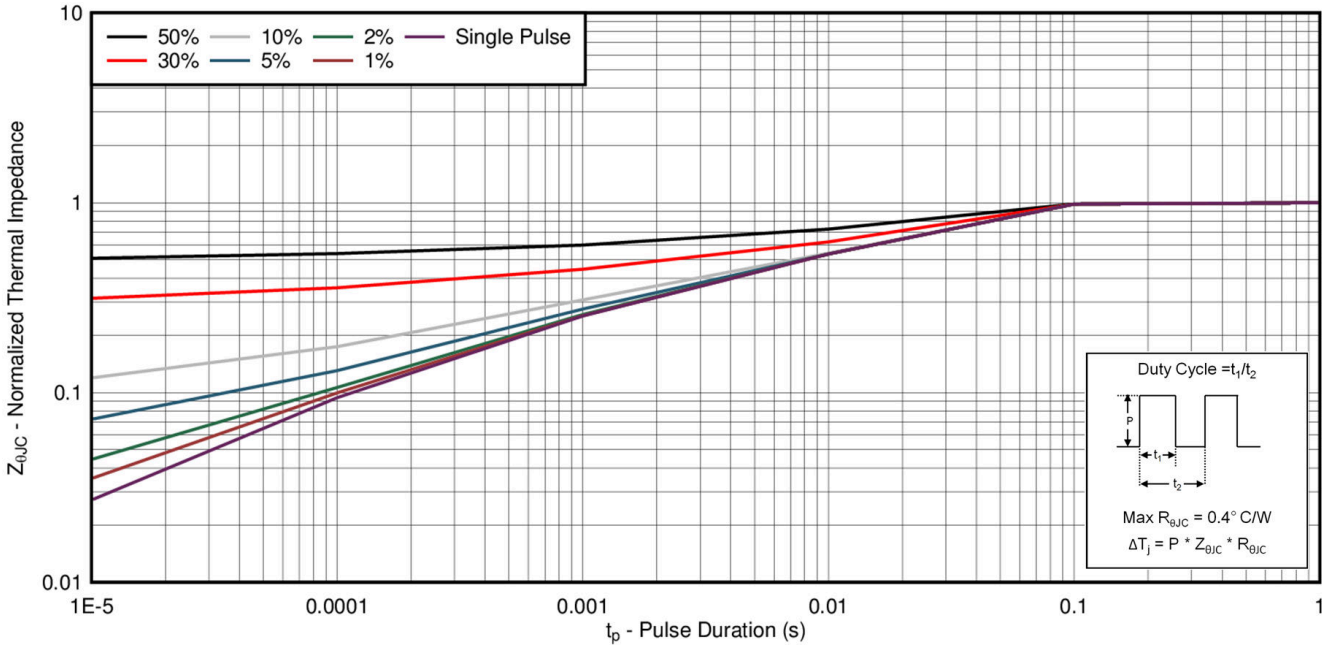


Figure 4-1. Transient Thermal Impedance

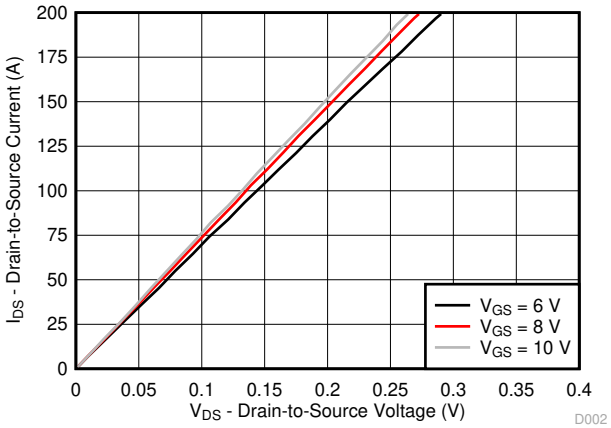
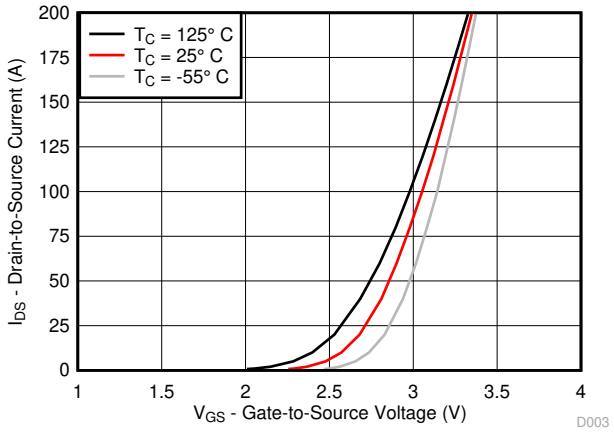
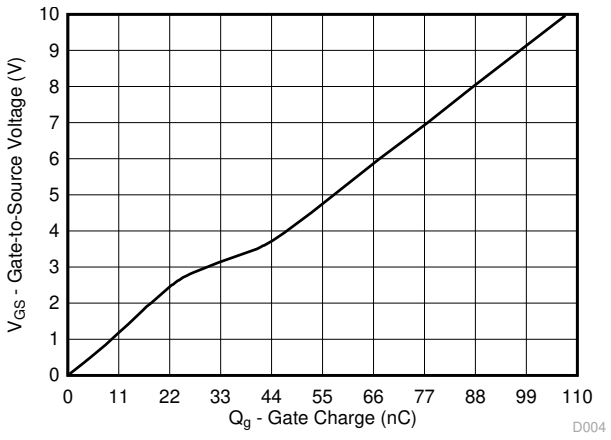


Figure 4-2. Saturation Characteristics



VDS = 5 V

Figure 4-3. Transfer Characteristics



V_{DS} = 50 V I_D = 100 A

Figure 4-4. Gate Charge

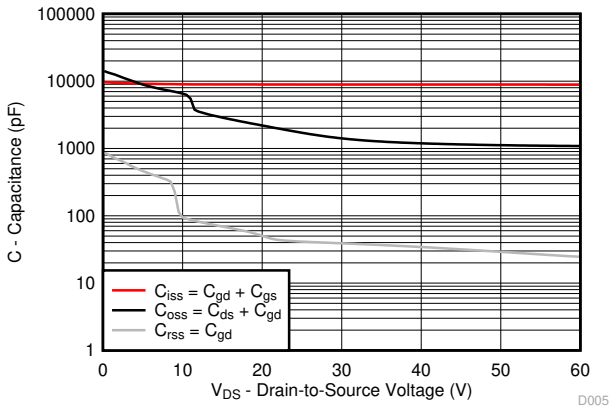
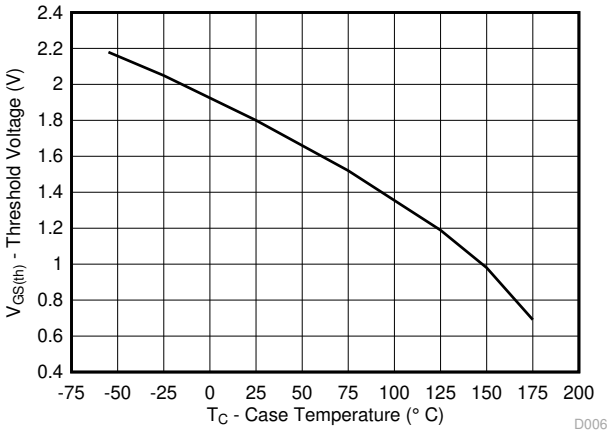


Figure 4-5. Capacitance



I_D = 250 µA

Figure 4-6. Threshold Voltage vs Temperature

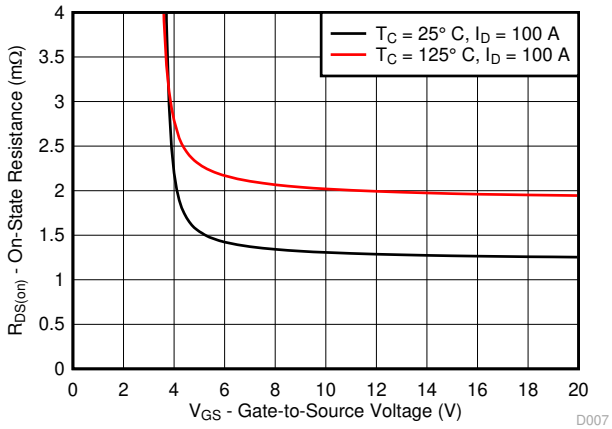
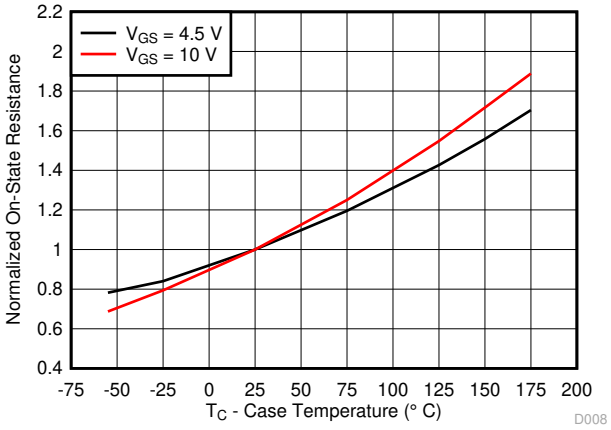


Figure 4-7. On-State Resistance vs Gate-to-Source Voltage



I_D = 100 A

Figure 4-8. Normalized On-State Resistance vs Temperature

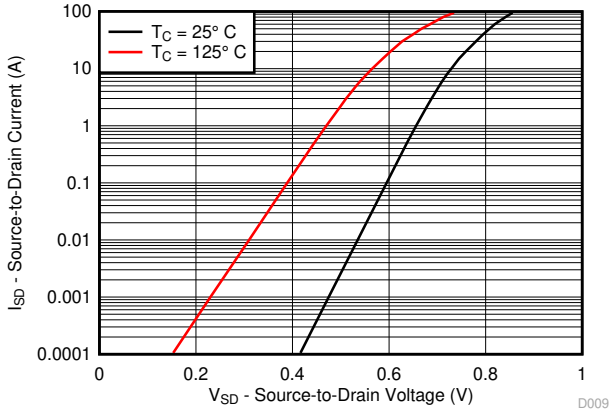
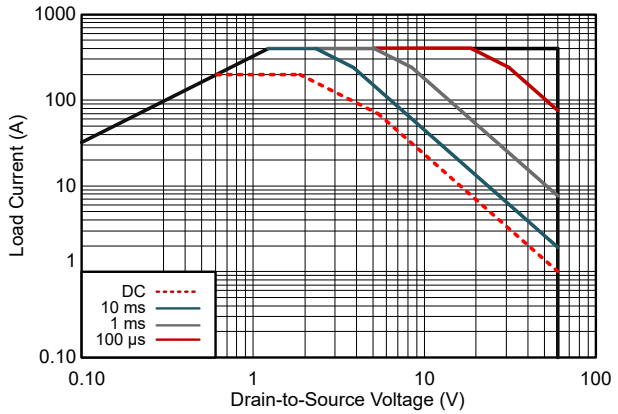


Figure 4-9. Typical Diode Forward Voltage



Single Pulse Max $R_{\theta JC}$ = 0.4°C/W

Figure 4-10. Maximum Safe Operating Area

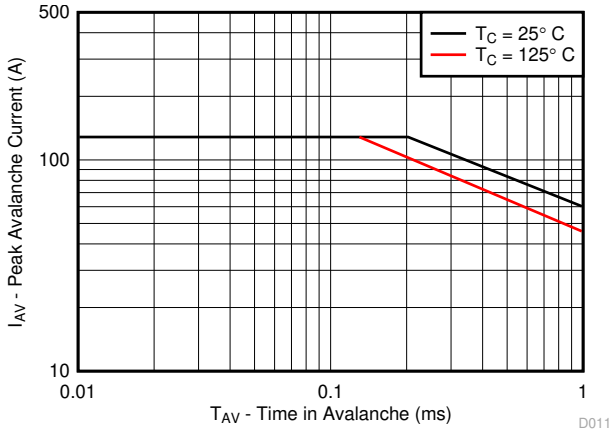


Figure 4-11. Single Pulse Unclamped Inductive Switching

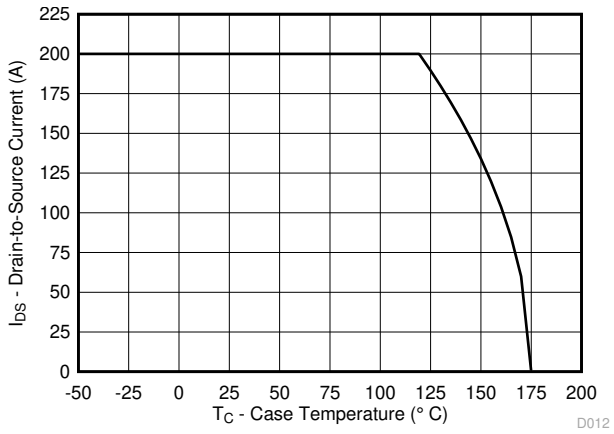


Figure 4-12. Maximum Drain Current vs Temperature

5 Device and Documentation Support

5.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

5.2 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

5.3 Trademarks

NexFET™ and TI E2E™ are trademarks of Texas Instruments.
All trademarks are the property of their respective owners.

5.4 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

5.5 Glossary

TI Glossary	This glossary lists and explains terms, acronyms, and definitions.

6 Revision History

Changes from Revision B (June 2023) to Revision C (March 2024) — **Page**

- Updated the numbering format for tables, figures, and cross-references throughout the document..... 1

Changes from Revision A (December 2017) to Revision B (June 2023) — **Page**

- Updated Figure 4-10 4

Changes from Revision * (March 2015) to Revision A (December 2017) — **Page**

- Updated Gate Charge curve 1
- Changed C_{OSS} values From: TYP = 1700pF MAX = 2210pF To: TYP = 1410 pF MAX = 1840pF in *Dynamic Characteristics* 3
- Changed Q_g values From: TYP = 83nC MAX = 108nC To: TYP = 108nC MAX = 140nC in the *Dynamic Characteristics* 3
- Changed $Q_{g(th)}$ value From: 12nC To: 17nC in the *Dynamic Characteristics* 3
- Changed $t_{d(on)}$ value From: 8ns To: 11ns in *Dynamic Characteristics*. 3
- Changed t_r value From: 17ns To: 5ns in *Dynamic Characteristics*. 3
- Changed $t_{d(off)}$ value From: 23ns To: 24ns in *Dynamic Characteristics*. 3
- Changed t_f value From: 12ns To: 4ns in *Dynamic Characteristics* 3
- Updated Figure 4-4. 4
- Updated Figure 4-5 4

7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CSD18536KCS	Active	Production	TO-220 (KCS) | 3	50 | TUBE	ROHS Exempt	SN	N/A for Pkg Type	-55 to 175	CSD18536KCS
CSD18536KCS.B	Active	Production	TO-220 (KCS) | 3	50 | TUBE	ROHS Exempt	SN	N/A for Pkg Type	-55 to 175	CSD18536KCS

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

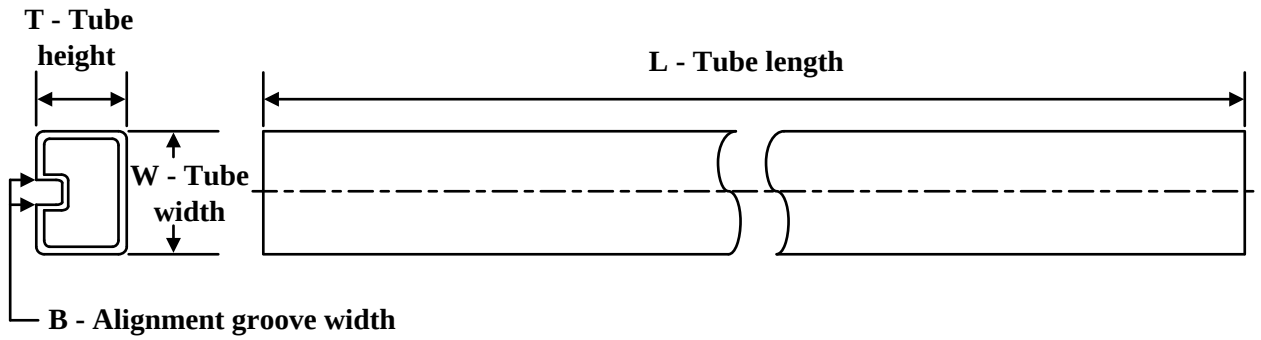
(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

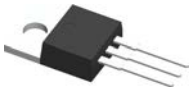
TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CSD18536KCS	KCS	TO-220	3	50	532	34.1	700	9.6
CSD18536KCS.B	KCS	TO-220	3	50	532	34.1	700	9.6

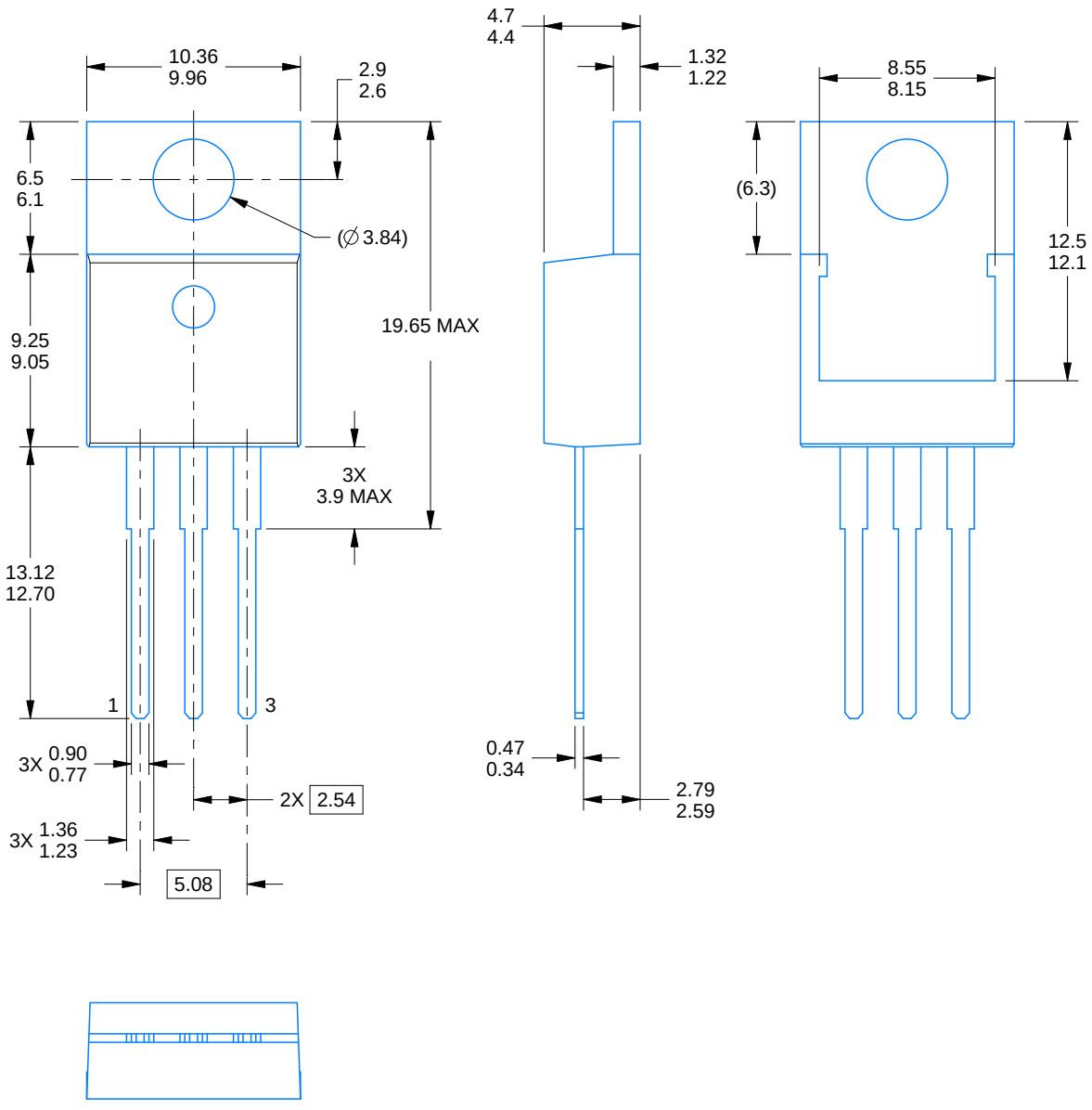
KCS0003B



PACKAGE OUTLINE

TO-220 - 19.65 mm max height

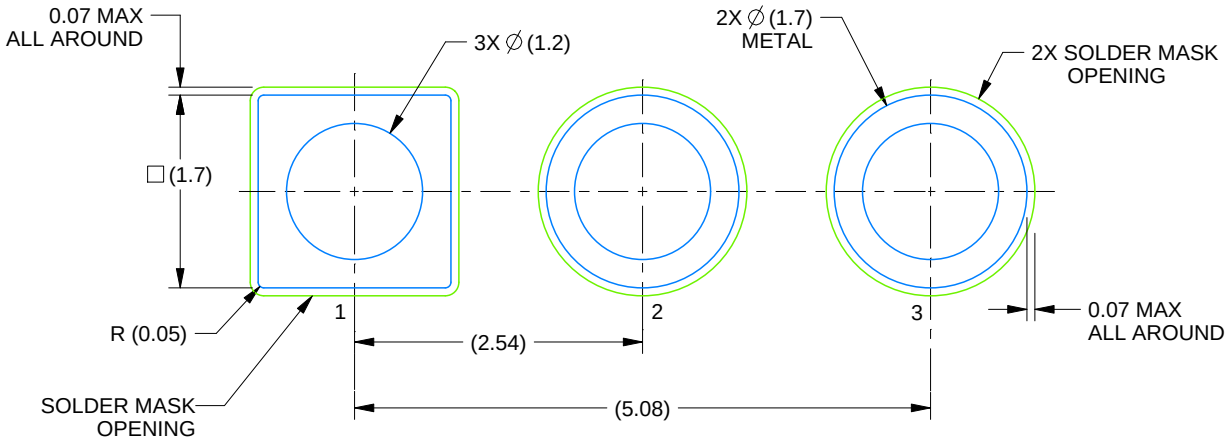
TO-220



4222214/B 08/2018

NOTES:

1. Dimensions are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC registration TO-220.



LAND PATTERN EXAMPLE
NON-SOLDER MASK DEFINED
SCALE:15X

4222214/B 08/2018

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES “AS IS” AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI’s products are provided subject to TI’s Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI’s provision of these resources does not expand or otherwise alter TI’s applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265